

<b>Notice of References Cited</b>	Application/Control No. 10/780,728		Applicant(s)/Patent Under Reexamination CHERN LIN ET AL.	
	Examiner Mary Lynn F. Theisen		Art Unit 1732	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,820,632 A	10-1998	Constantz et al.	423/308
X	B	US-6,340,648 B1	01-2002	Imura et al.	501/80
X	C	US-6,547,866 B1	04-2003	Edwards et al.	106/35
X	D	US-2003/0078317 A1	04-2003	Lin et al.	523/116
X	E	US-6,616,742 B2	09-2003	Lin et al.	106/35
X	F	US-6,648,960 B1	11-2003	Lin et al.	106/690
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.